

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	110578676	TANEYA ET AL.
Examiner	Art Unit	
MARCOS BATISTA	2617	

SEARCHED

Class	Subclass	Date	Examiner
455	566	11/4/2008	mb
455	575.3	4/16/2008	mb

SEARCH NOTES

Search Notes	Date	Examiner
Consulted with TA - Yogesh Aggarwal	4/16/2008	mb
Consulted with Lun-Yi Lao	4/16/2008	mb
East Search	4/16/2008	mb
Inventor's Name Seach	4/16/2008	mb
Consulted with Rafael Perez Gutierrez	11/4/2008	mb
Consulted with Rafael Perez Gutierrez	6/15/2009	mb

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner